High resolution scanning tunneling spectroscopy of ultrathin Pb on Si(111)-(6 6) substrate

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A bstract

The electronic structure of Si(111)-(6 6)Au surface covered with submonolayer amount of Pb is investigated using scanning tunneling spectroscopy. A lready in small islands of Pb with thickness of 1 M L Pb₍₁₁₁₎ and with the diam eter of only about 2 nm we detected the quantized electronic state with energy 0.55 eV below the Ferm i level. Sim ilarly, the I(V) characteristics m ade for the Si(111)-(6 6)Au surface reveal a localized energy state 0.3 eV below the Ferm i level. These energies result from thing of the theoretical curves to the experimental data. The calculations are based on tight binding H ubbard m odel. The theoretical calculations clearly show prominent m odi cation of the I(V) curve due to variation of electronic and topographic properties of the STM tip apex.

Key words: Scanning tunneling spectroscopies, Surface electronic phenom ena, M etallic quantum wells, Tunneling PACS: 73.20.-r, 73.20 At, 73.40 G k, 73.63 K v, 73.63 H s

1. Introduction

Spectacular observations of electron con nement in Pb quantum wells (QW) have been realized in several photoemission spectroscopy (UPS) experiments [1], [2], [3], helium atom scattering [4], [5], and in in situ electrical resistivity measurements [6]. These techniques only provide surface electronic structure information averaged over a large surface area. In contrast, the scanning tunneling microscopy (STM), and scanning

tunneling spectroscopy (STS) allow one to study topographic and electronic structure with atom ic scale resolution [7], [8], and [9]. STS was also successfully applied for studying the quantum size e ects (QSE) in well de ned Pb islands, starting with the sm allest thickness of 3 m onoatom ic layers (ML) [10] and laterally rather large. In our previous UPS study we have shown that even 1 M L thick layer of P b shows distinct Q SE discrete electronic level. However, clear experim ental evidence directly relating quantized electronic states with lateral size of individual islands has not been reported. In the initial stage of ultrathin lm growth, for very low coverage, e ects associated with form ation of quantum dots are expected and the STS technique is particularly well suited to

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detect and to study these phenom ena. How ever, quantitative analysis of tunneling current versus sample bias I(V) dependence requires know ledge of the tunneling tip shape and its electronic structure. B oth parameters are in general unknow n.

In this paper, we investigate the topographic and electronic structure of sm all Pb islands and single Pb atom s on Si(111)-(6 6)Au surface by means of low temperature atom ically resolved scanning tunneling spectroscopy. The experimental studies are supplemented by theoretical ones based on a tight binding model, where the I(V) characteristics are calculated using the non-equilibrium K eldysh G reen function form alism. We demonstrate how (unavoidable during STS experiment) modi cation of the tunneling tip apex by uncontrolled attaching or detaching of a single atom, modify the I(V) curve. M oreover, we present existence of wellde ned Q SE electronic level in 1 M L thick Pb island with diameter sm aller than 1.5 nm.

2. Experim entalm ethod and results

The experim entwas carried out in UHV cham ber equipped with an Omicron variable temperature STM and RHEED. After preparation of Si(111) (6 6)Au surface under RHEED control at room tem perature (for further details of sam ple preparation see [1]) the sample was transferred into a cooled STM stage where a submonolayer am ount of Pb was evaporated.STM tips were produced by conventional electrochem ical etching of tungsten wire, and were further conditioned in in situ via prolonged scanning over a clean Si(111)-(7 7) surface with sample bias set within the range from -5 to -10 V. Tunneling spectroscopy was performed simultaneously with topography m easurem ents at every point of the surface that is im aged by STM, or every fth point sam pled during a scan. Typical STS data le contained 5000 I(V) curves with 200 I(V) points each. The presented below STS curves are averages of several individual curves collected within indicated areas. The number of these curves spanned from 16 for sm allest area, to 68 in the case of the largest area. The area sizes were chosen in such a way that the

individual curves were very much the same shape, typically within 20% of the tunneling current at any bias. This inaccuracy, due to averaging, was further reduced. We stress that we have avoided presenting of data from areas where shapes of neighboring I-V curves were scattered and noisy. We are aware that averaging procedure applied for su ciently large number of curves (even if they di er strongly) supplies nice, sm ooth curve. The I(V) characteristics were acquired with feedback loop inactive. During the measurements the tem – perature of the sam ple was about 130 K and the base pressure was less than 6 10 ¹¹ m bar.

Figure 1 shows example of high resolution topographic data of the Si(111)-(6 6)Au surface with deposited 0.2 M L of Pb. The image shows separate P b islands with diam eter ranging from about 1 nm to maximum of about 3 nm. At the sample bias equal to -1.5 V the height of the largest islands is close to 0.4 nm . This corresponds to the height of a continuous m onolayer of Pb (111). The visible smallest species have the width and the heightequalto1nm and 0.17nm, respectively. The largest islands have at tops whereas the sm aller appear as rounded features. We believe that the sm allest features are single P b atom s, sim ilarly as in the samples with coverage as low as 0.012 M L of Pb (111) [11], whereas the largest one possesses crystalline structure continuous m onoatom ic layer ofPb(111) [1].

In comparison with the constant current im aging m ode operation of the STM, the spectroscopic m ode requires cleanness and extra stability of the tip. Although the STM tip was carefully conditioned and its quality was checked during a control scan over freshly prepared Si(111)-(7 7) surface, we have seen frequently reversible or irreversible changes of the tip properties. Although these changes in uenced only slightly the topographic in ages of the surface, they have modi ed strongly the shape of the I-V tunneling characteristics. This is shown in Fig. 2 and 3. In Fig. 2 the tunneling characteristics taken on Si(111)-(6 6) A u surface exhibit negative di erential resistance.W e stress that this phenom enon is related to the tip properties. In otherm easurem ents, m ade with other tip, the region with negative di erential conductivity appeared only as shoulder show n

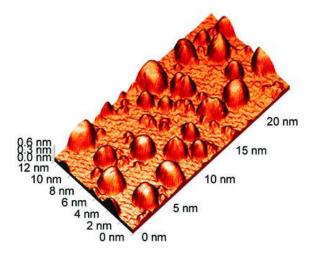


Fig. 1. STM im age of Si(111)-(6 6)Au surface covered with 0.2 M L of Pb.The sam ple bias voltage was -1.5 V and the tunneling current was 0.5 nA.The largest islands have thickness equivalent continuous Pb (111) M L.The sm allest species visible are single Pb atom s.Periodic m odulation of the Si(111)-(6 6)Au reconstruction is also visible.

in Fig. 3. In general the negative di erential conductivity was observed for the tips giving worse resolved topographic in ages.

3. Theoretical description

In general, the tunneling current depends on the Local D ensity of States (LDOS) of both tip and the sam ple [12], but in the most earlier experim ental works no particular attention to the details of the LDOS of the tungsten tip has been payed. In order to explain the occurrence of the negative differential resistance and to correlate it with the tip shape, we have developed a model of the tunneling system with the tip which may attach a single atom or a cluster of atom s - a case which occurs frequently during scans.

The system composed of surface, island and STM tip, Fig.4, is described by following Ham il-tonian

$$H = H_{STM} + H_{tip} + H_{isl} + H_{surf} + H_{int}; \quad (1)$$

where

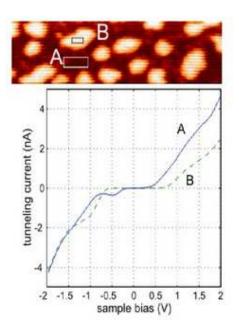


Fig.2. 40nm 10 nm (400 100 pixels) STM image and I(V) characteristics of Si(111)-(6 6)Au surface covered with 0.2 M L of the Pb.The characteristics were acquired every fth pixel.The curves A and B in the low erpanelare averages over corresponding areas A and B shown in the upper panel of the Figure.The feedback loop was opened at 3.1 nA and -1.76 V.

$$H_{STM} = \underset{\substack{k \ 2 \ STM}}{k \ 2 \ STM} k_k^+ Q_k$$
(2)

and

Х

$$H_{surf} = \sum_{\substack{k \ k \ surf}}^{X} c_{k}^{\dagger} q_{k}$$
(3)

stand for the STM and the surface electrodes electrons with the energies $_k$. The STM tip ism odeled by a single atom with the energy level "_0

$$H_{tip} = "_0 c_0^+ c_0 :$$
 (4)

S in ilarly the island is described by the energy level $\mathbf{"}_{i}$

$$H_{isl} = "_i c_i^{\dagger} c_i :$$
 (5)

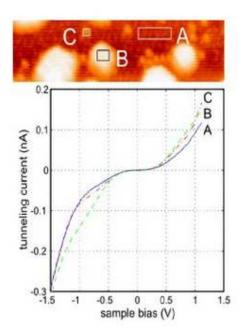


Fig. 3. 20nm 5 nm (100 25 pixels) STM in age and I(V) characteristics of Si(111)–(6 6)A u surface covered with 0.2 M L of Pb. The characteristics were acquired every pixel. The curves A, B, and C in the lower panel are averages over corresponding areas A, B, and C shown in the upper panel of the Figure. The feedback loop was opened at 0.5 nA and -1.76 V.

The interactions between dierent subsystems are in the form

$$H_{int} = \bigvee_{\substack{k \ge STM \\ k \ge STM \\ k \ge Surf}} V_{k0}c_{k}^{+}c_{0} + t_{i0}c_{0}^{+}c_{i}$$

$$(6)$$

with V_{k0} being a hybridization between the STM electrode and the STM tip, t_{i0} -the hopping integral between electrons on the island and those in the tip, and V_{ki} -hybridization connecting the surface and the island. Note that we have om itted the spin index in above equations as in this case spin channels can be treated separately.

In order to calculate the STM tunneling current

we follow the standard procedure [13] and the result reads

$$I = \frac{2e}{\sim} \int_{1}^{Z_{+}} \frac{dE}{2} T(E) [f_{STM}(E) f_{surf}(E)]; \quad (7)$$

where $f_{\text{STM}\ (\text{surf})}(\!E\!$) is the Ferm i distribution function and the transm ittance T (E) is given in the form

$$T(E) = _{STM}(E) _{surf}(E) j G_{i0}^{r}(E) j^{2}$$
: (8)

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In num erical calculations we have chosen a constant density of states in the STM electrode and the density of states in the surface $_{surf}(E) = E + 0.06 f^{:4}$. The parameter t_{i0} is equal to 2.5 eV, which corresponds to the tip-surface distance z 4 A [14,15]. Such a sm allvalue of z steam s from the fact that we have assumed the only single tunneling channel. In realistic situation there are many of them and if we take this e ect into account the distance z will be larger.

To make comparison to the experiment and reproduce the STM data shown in Figs. 2 and 3, we have used two di erent model tips. The tip is described by a particle coupled to the STM electrode. Their coupling parameter STM depends on the tip sharpness and re ects a size of the particle attached to the tip electrode. The rst one, which reproduces the results shown in Fig. 2, is characterized by a particle with energy level $"_0 = 0.8 \text{ eV}$ strongly coupled to the STM electrode _{STM} = 5 eV. This corresponds to the real STM tip with sm all curvature - blunt tip (BT), giving low resolution topographic in ages (see Fig. 2). The other one, reproducing the results shown in Fig. 3 and giving high resolution topographic in ages, is a sharp tip (ST) modeled by single atom with $"_0 = 2.0 \text{ eV}$ weakly coupled to the STM electrode STM = 0.7 eV. Sm allvalue for the "sharp" tip describes localized,

atom ic-like character of a single atom .Large coupling parameter represents a large cluster of atom s with bulk-like electronic structure. This is shown schematically in Fig.4.

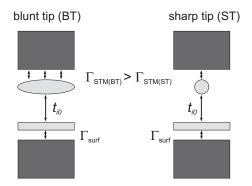


Fig. 4. Schem atic representation of two tips considered in the tunneling current calculations. Larger coupling parameter $_{\rm STM}$ represents a large cluster of atom s with bulk-like electronic structure. Sm aller value of the coupling parameter re ects localized, atom ic-like character of a single atom at the tip apex.

Figure 5(a) shows the comparison of the experimental data of the STM current-voltage characteristic of the Pb island (curve B in Fig.2) and the theoretical calculations with a blunt tip. The theoretical thas been done with assumption that the Pb island is weakly coupled to the surface surf =0:6 eV and a single particle state "i is at energy

0.55 eV with respect to the Ferm i energy. We identify this single particle state energy with the quantum size state level in 1 M L of Pb, as it was determ ined in photoem ission experiment [1]. The corresponding comparison for a sharp tip (curve B in Fig. 3) is shown in Fig. 5 (b). Note that the parameters characterizing the Pb island and the tip-surface distance are exactly the same as those previously used. Such huge modi cations of the tunneling current are due to the properties of the tip only.

In order to reproduce the I(V) characteristics of the Si(111)–(6x6)A u surface, we assumed that tunneling takes place into a small region of the surface, containing one or a few atoms, articially isolated from the rest of the sample, which therefore can be also modeled as an island. This island is characterized by energy level"_i = 0.3 eV and the coupling to the rest of the surface surf is equal to 4 eV. The

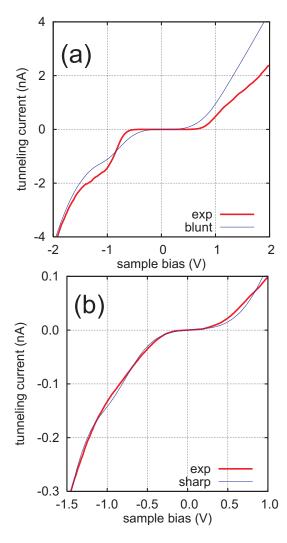


Fig.5. The comparison of the I(V) experimental data of the tunneling current to the Pb island (thick line) with theoretical t (thin line) for the blunt tip (a), and for the sharp tip (b), respectively. The model parameters are described in the text.

single particle energy level for Si(111)-(6x6)Au surface corresponds to energy of a at electron energy band found in photoem ission experim ent [16]. The other param eters are the sam e as previously used. The energies of the particles at the tip were chosen to t the calculated curves to the experim ental ones. The only consequence of their variation was change of the curves slope at higher biases but not the positions of the I-V curves negative regions

The comparison of the theoretical calculations

with the experim ental data is shown in Fig. 6(a). Note the negative behavior of the I(V) character-

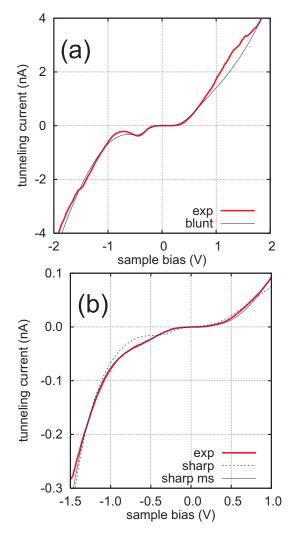


Fig. 6. The comparison of the I(V) data of the tunneling current to the Si(111)-(6 6)Au island (thick line) with theoretical t (thin line) for the blunt tip (a), and for the sharp tip (b), respectively. In (b) the dotted line corresponds to the coupling $_{\rm surf} = 4$ eV and the solid one is for $_{\rm surf} = 1$ eV. The other parameters are described in the text.

istic in a small region below sample bias V = 0.5V.Corresponding results for the sharp tip are displayed in Fig.6(b).

If we use the same parameters characterizing the island as those in Fig. 5(b) and sharp tip, we get quite reasonable agreement with the experimental

data (dotted line), except for sm all region around V = 0.5 V, which is the hallmark of the negative I(V) characteristic observed in Fig. 6(a). To im -

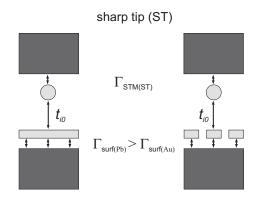


Fig. 7. Schem atic representation of two surfaces modeled by islands. Larger coupling parameter $_{surf(Pb)}$ represents Pb island. Sm aller value of the coupling parameter $_{surf(Au)}$ describes sm all area of surface embedded in the surrounding (6 6)Au reconstruction and weakly coupled to the substrate.

prove this e ect we had to make the coupling of the island to the surface smaller. A four times smaller

surf gives excellent agreem ent with the experimental results (thin solid line). We believe that the use of the sm aller value of surf has a physical origin and can be explained in the following way. For a sharp tip the tunneling takes place to a narrow er region of the surface than in the case the blunt tip. This is well a understood and accepted phenom enon. Therefore the surface region modelled by the isolated island is also sm aller, containing less Au atom s (Fig.7). Further, if we assume that each atom on the island is equally coupled to the surface we arrive at the conclusion that in this case the coupling surf should be smaller. Only with this assumption we were able to get a perfect agreem ent with the experim ent. Note that in the case of the Pb island no such modi cation of surf is necessary, as the tunneling region is bounded by the Pb island itself. A sone can read o from Fig.1 the Pb islands are narrow and, more importantly, quite high (a few of A), thus the tunneling directly into the surface can be neglected.

4. Conclusions

In conclusion we have perform ed STS studies of ultrathin Pb on Si(111)-(6 6)Au surface supplem ented by theoretical calculations based on tight binding model. A lready in sm all islands of P b with thickness of $1 \text{ M L Pb}_{(111)}$ and with the diam eter of only about 2 nm the quantized electronic state with energy 0:55 eV below the Ferm i level is detected.W e identify this energy with the quantum well state of 1 M L thick Pb island seen in the UPS experiment [1]. Similarly, the I(V) characteristics made for the Si(111)-(6 6)Au surface reveal localized energy state 0:3 eV below the Ferm i level, previously detected in photoem ission [16]. The obtained results lead also to the important conclusion that m easured I(V) characteristics should be taken with care, as they strongly depend on the shape and the properties of the tip itself, which is often om itted while discussing and interpreting experim entaldata.

A cknow ledgem ents

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